

Notice of References Cited	Application/Control No. 10/648,437	Applicant(s)/Patent Under Reexamination KIM, JIN-CHEON	
	Examiner Hiep T. Nguyen	Art Unit 2187	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,061,710	05-2000	Eickemeyer et al.	718/107
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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